

## General features

Type	$V_{CES}$	$V_{CE(sat)Max @25^\circ C}$	$I_C @100^\circ C$
STGD6NC60H	600V	<2.5V	7A

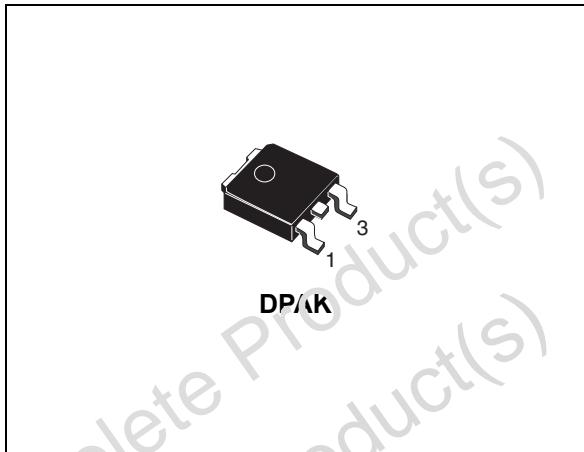
- Low on voltage drop ( $V_{cesat}$ )
- Low  $C_{RES} / C_{IES}$  ratio (no cross-conduction susceptibility)
- High frequency operation

## Description

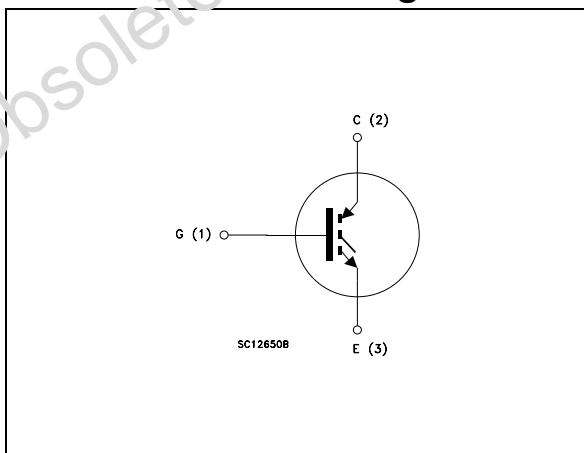
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "H" identifies a family optimized for high frequency application in order to achieve very high switching performances (reduced t<sub>fall</sub>) maintaining a low voltage drop.

## Applications

- High frequency inverters
- SMPS and PFC in both hard switch and resonant topologies
- Motor drivers



## Internal schematic diagram



## Order code

Part number	Marking	Package	Packaging
STGD6NC60HT4	GD6NC60H	DPAK	Tape & reel

## Contents

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# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage ( $V_{GS} = 0$ )	600	V
$I_C^{(1)}$	Collector current (continuous) at $T_C = 25^\circ\text{C}$	15	A
$I_C^{(1)}$	Collector current (continuous) at $T_C = 100^\circ\text{C}$	7	A
$I_{CM}^{(2)}$	Collector current (pulsed)	21	A
$V_{GE}$	Gate-emitter voltage	$\pm 20$	V
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	56	W
$T_{stg}$	Storage temperature	-55 to 150	$^\circ\text{C}$
$T_j$	Operating junction temperature		
$T_l$	Maximum lead temperature for soldering purpose (for 10sec. 1.6 mm from case)	300	$^\circ\text{C}$

1. Calculated according to the iterative formula::

$$I_C(T_C) = \frac{T_{JMAX} - T_C}{R_{THJ} \cdot C_{ESAT(MAX)}(T_C, I_C)}$$

2. Pulse width limited by max junction temperature

**Table 2. Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	2	$^\circ\text{C/W}$
$R_{thi-amb}$	Thermal resistance junction-ambient max	62.5	$^\circ\text{C/W}$

## 2 Electrical characteristics

( $T_{CASE}=25^{\circ}\text{C}$  unless otherwise specified)

**Table 3. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{BR(CES)}$	Collector-emitter breakdown voltage	$I_C=1\text{mA}, V_{GE}=0$	600			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE}=15\text{V}, I_C=3\text{A}$ $V_{GE}=15\text{V}, I_C=3\text{A}, T_c=125^{\circ}\text{C}$		1.9 1.7	2.5	V V
$V_{GE(\text{th})}$	Gate threshold voltage	$V_{CE}=V_{GE}, I_C=250\ \mu\text{A}$	3.75		5.75	V
$I_{CES}$	Collector cut-off current ( $V_{GE} = 0$ )	$V_{CE}=\text{Max rating}, T_C=25^{\circ}\text{C}$ $V_{CE}=\text{Max rating}, T_C=125^{\circ}\text{C}$			10 1	$\mu\text{A}$ mA
$I_{GES}$	Gate-emitter leakage current ( $V_{CE} = 0$ )	$V_{GE}=\pm20\text{V}, V_{CE}=0$			$\pm100$	nA
$g_{fs}$	Forward transconductance	$V_{CE} = 15\text{V}, I_C=3\text{A}$		3		s

**Table 4. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{ies}$	Input capacitance			205		pF
$C_{oes}$	Output capacitance	$V_{CE} = 25\text{V}, f = 1\text{MHz}, V_{GE} = 0$		32		pF
$C_{res}$	Reverse transfer capacitance			5.5		pF
$Q_g$	Total gate charge	$V_{CE} = 390\text{V}, I_C = 3\text{A}, V_{GE} = 15\text{V}$		13.6		nC
$Q_{ge}$	Gate-emitter charge			3.4		nC
$Q_{gc}$	Gate-collector charge	(see Figure 16)		5.1		nC
$I_{CL}$	Turn-off SOA minimum current	$V_{clamp}=390\text{V}, T_j=150^{\circ}\text{C}, R_G=10\Omega, V_{GE}=15\text{V}$		19		A

**Table 5. Switching on/off (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$ $(di/dt)_{on}$	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 3A$ $R_G = 10\Omega, V_{GE} = 15V,$ $T_j = 25^\circ C$ (see Figure 17)		12 5 612		ns ns A/ $\mu$ s
$t_{d(on)}$ $t_r$ $(di/dt)_{on}$	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 3A$ $R_G = 10\Omega, V_{GE} = 15V,$ $T_j = 125^\circ C$ (see Figure 17)		13 4.3 560		ns ns A/ $\mu$ s
$t_r(V_{off})$ $t_{d(off)}$ $t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390V, I_C = 3A,$ $R_{GE} = 10\Omega, V_{GE} = 15V, T_j = 25^\circ C$ (see Figure 17)		40 76 130		ns ns ns
$t_r(V_{off})$ $t_{d(off)}$ $t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390V, I_C = 3A,$ $R_{GE} = 10\Omega, V_{GE} = 15V$ $T_j = 125^\circ C$ (see Figure 17)		60 98 124		ns ns ns

**Table 6. Switching energy (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{on}^{(1)}$ $E_{off}^{(2)}$ $E_{ts}$	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 3A$ $R_G = 10\Omega, V_{GE} = 15V,$ $T_j = 25^\circ C$ (see Figure 17)		20 68 88		$\mu J$ $\mu J$ $\mu J$
$E_{on}^{(1)}$ $E_{off}^{(2)}$ $E_{ts}$	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 3A$ $R_G = 10\Omega, V_{GE} = 15V,$ $T_j = 125^\circ C$ (see Figure 17)		37 93 130		$\mu J$ $\mu J$ $\mu J$

1.  $E_{on}$  is the turn-on losses when a typical diode is used in the test circuit in Figure 17. If the IGBT is offered in a package with a co-pak diode, the co-pak diode is used as external diode. IGBTs & Diode are at the same temperature ( $25^\circ C$  and  $125^\circ C$ )
2. Turn-off losses include also the tail of the collector current

## 2.1 Electrical characteristics (curves)

Figure 1. Output characteristics

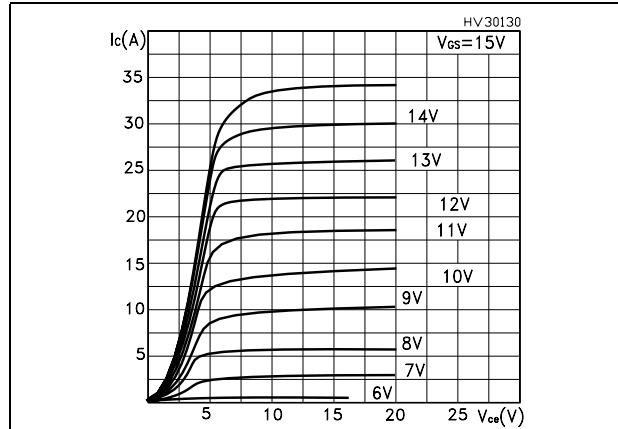


Figure 2. Transfer characteristics

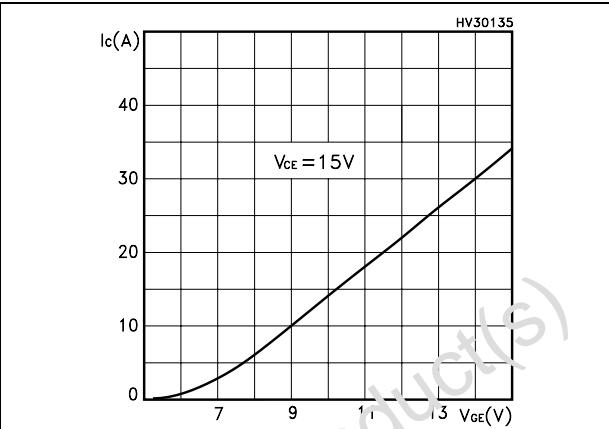


Figure 3. Transconductance

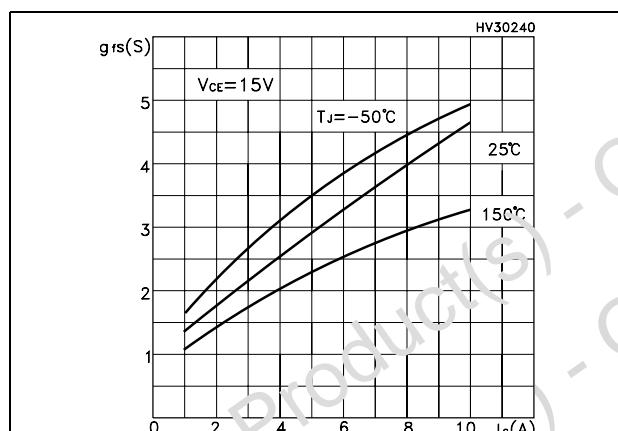


Figure 4. Collector-emitter on voltage vs temperature

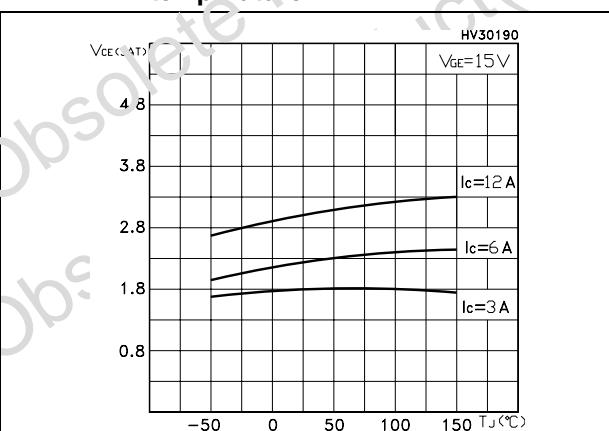


Figure 5. Gate charge vs gate-source voltage

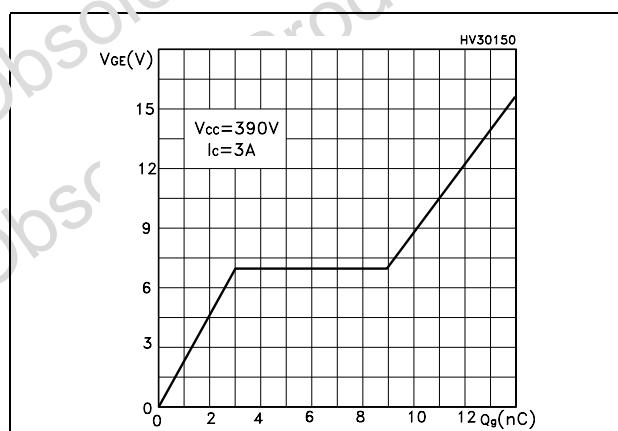
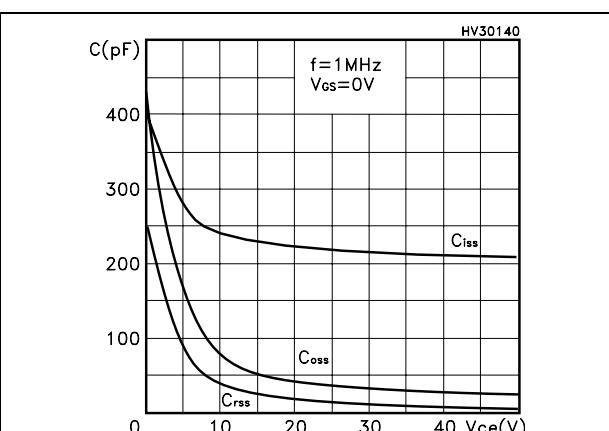


Figure 6. Capacitance variations



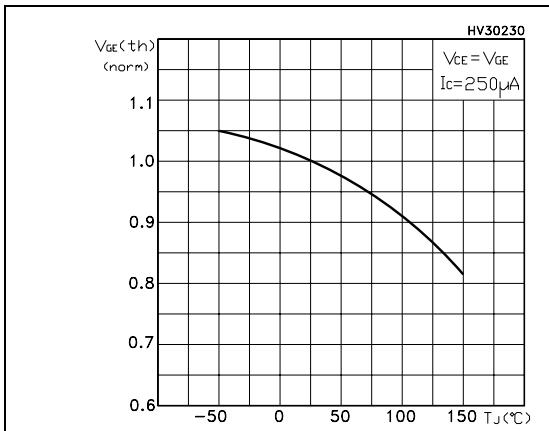
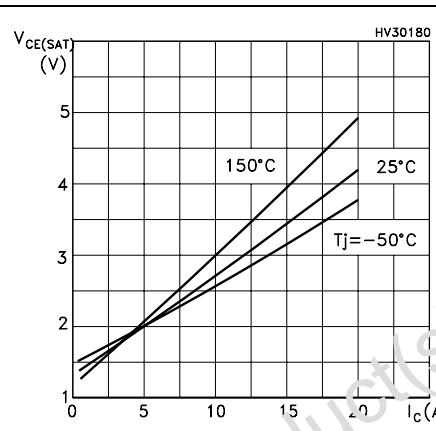
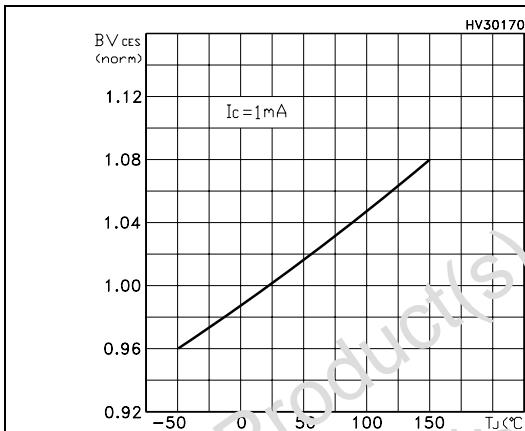
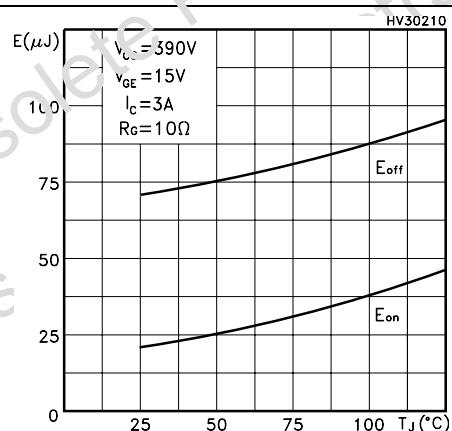
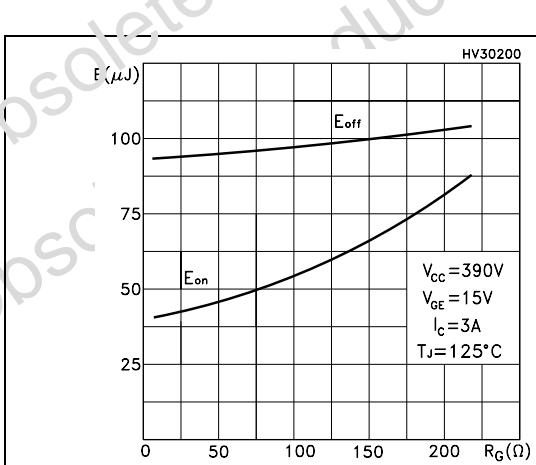
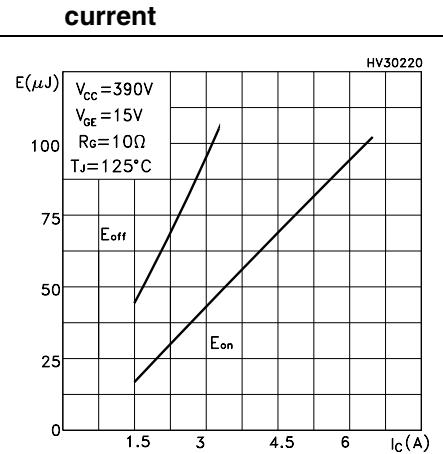
**Figure 7. Normalized gate threshold voltage vs temperature****Figure 8. Collector-emitter on voltage vs collector current****Figure 9. Normalized breakdown voltage vs temperature****Figure 10. Switching losses vs temperature****Figure 11. Switching losses vs gate resistance****Figure 12. Switching losses vs collector current**

Figure 13. Thermal impedance

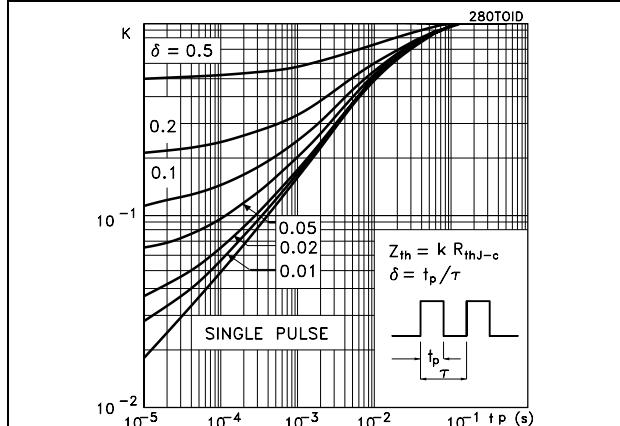
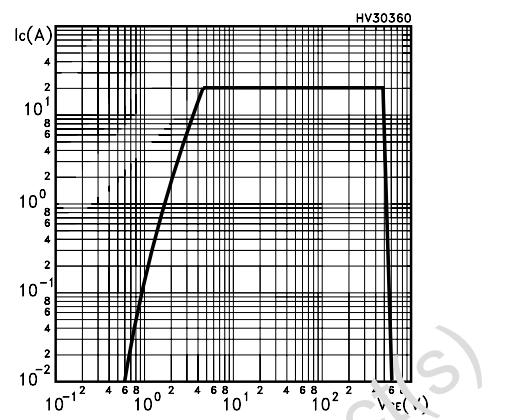
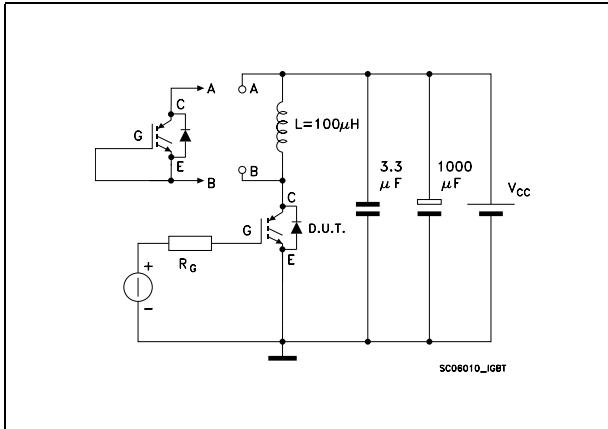


Figure 14. Turn-off SOA

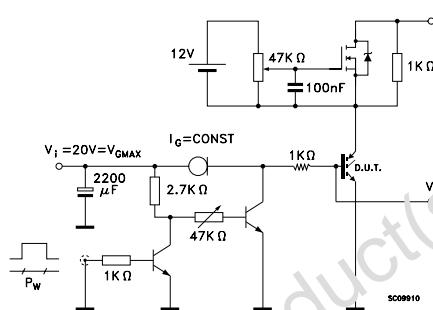


### 3 Test circuit

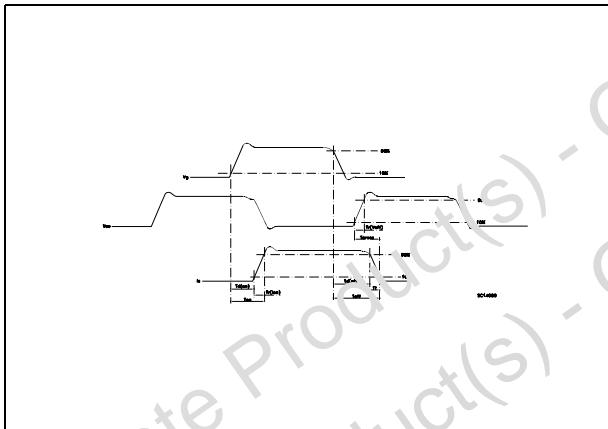
**Figure 15. Test circuit for inductive load switching**



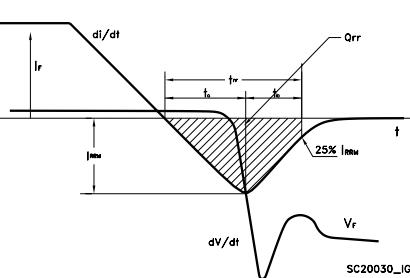
**Figure 16. Gate charge test circuit**



**Figure 17. Switching waveform**



**Figure 18. Diode recovery time waveform**

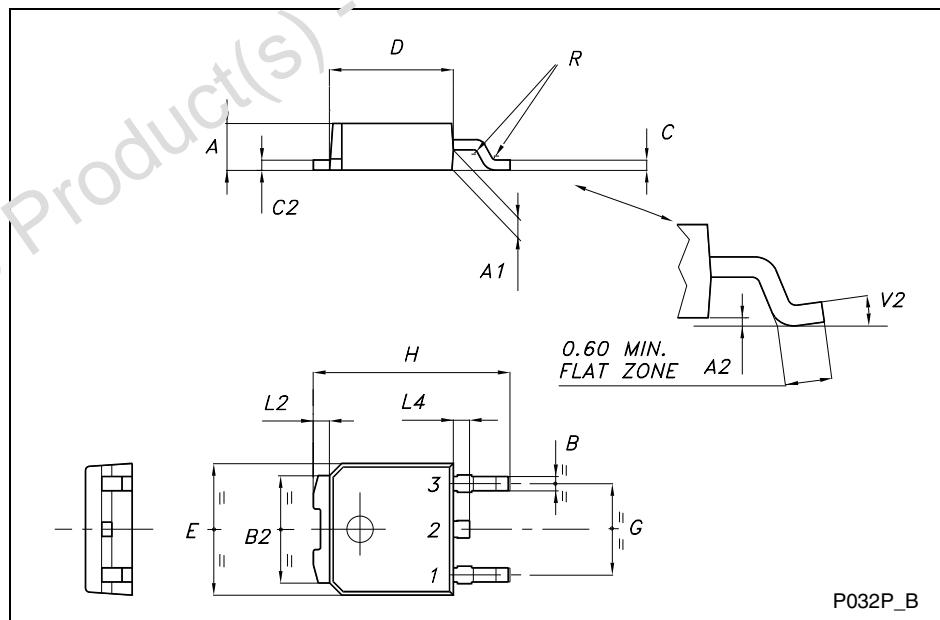


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com)

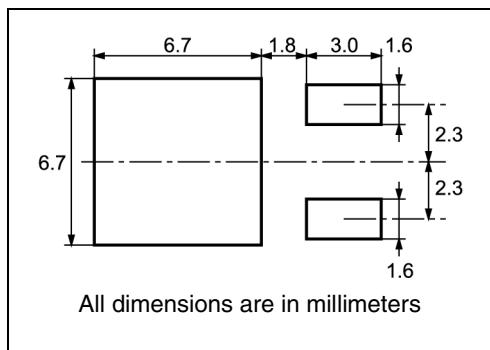
## TO-252 (DPAK) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.20		2.40	0.087		0.094
A1	0.90		1.10	0.035		0.043
A2	0.03		0.23	0.001		0.009
B	0.64		0.90	0.025		0.035
B2	5.20		5.40	0.204		0.215
C	0.45		0.60	0.018		0.024
C2	0.48		0.60	0.019		0.024
D	6.00		6.20	0.236		0.244
E	6.40		6.60	0.252		0.260
G	4.40		4.60	0.173		0.181
H	9.35		10.10	0.368		0.398
L2		0.8			0.031	
L4	0.60		1.00	0.024		0.039
V2	0°		8°	0°		0°

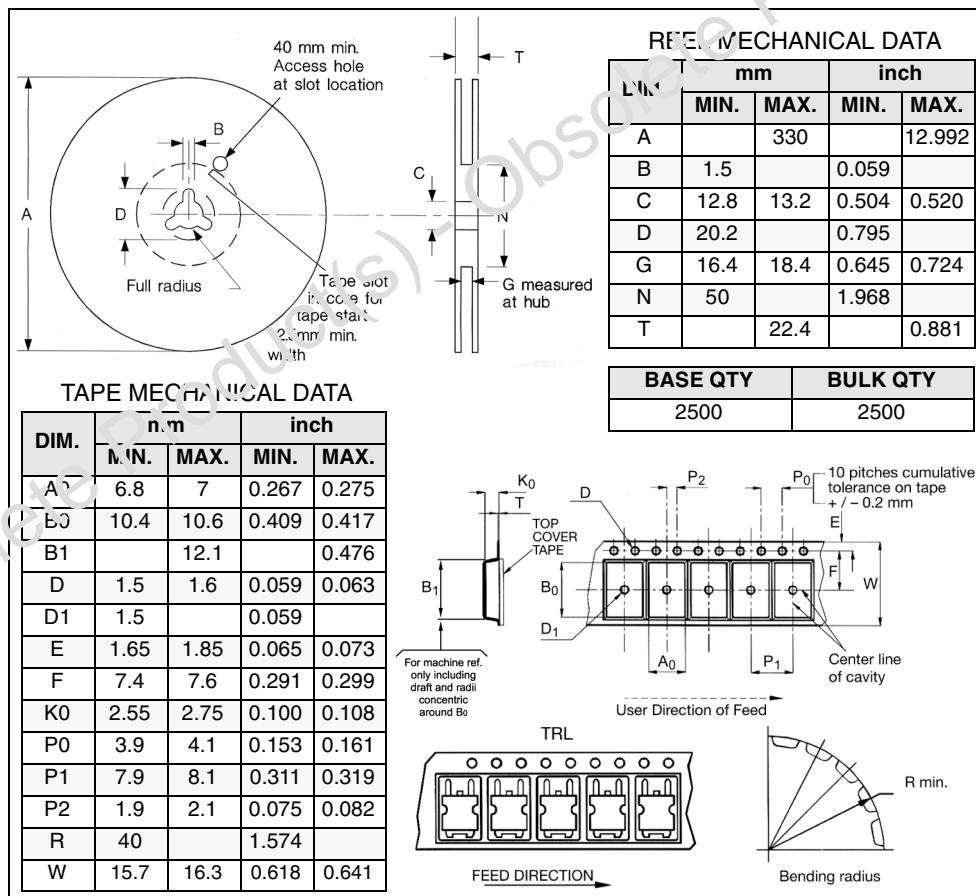


## 5 Packaging mechanical data

### DPAK FOOTPRINT



### TAPE AND REEL SHIPMENT



## 6 Revision history

**Table 7. Revision history**

Date	Revision	Changes
14-Jun-2005	1	First Release
07-Mar-2006	2	Complete version
08-Feb-2007	3	The document has been reformatted

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